

MCM 2012 B Series Specification

Product Name

Series

Size

Chip Common Mode Filter

MCM B Series

EIAJ 2012









MCM2012B SERIES (Chip Common Mode Filter) Engineering Specification

Features and Application

 Powerful components with composite co-fired material to solve EMI problem for high speed differential signal transmission line as USB, and LVDS, without distortion to high speed signal transmission.

1.PRODUCT DETAIL

Part No.	Imp. Com. (Ω)±25%	DCR	Rated Current	Rated Voltage	Withstand Voltage	Insulation Resistance
	@100MHz	Max. (Ω)	Max.(mA)	(V)	(V)	Min.(MΩ)
MCM2012B670GBE	67	0.40	400	10	25	200
MCM2012B900GBE	90	0.40	400	10	25	200
MCM2012B121GBE	120	0.40	400	10	25	200
MCM2012B161GBE	160	0.50	400	10	25	200
MCM2012B181GBE	180	0.50	400	10	25	200
MCM2012B221FBE	220	0.50	300	10	25	200
Test Instruments	Agilent E4991A RF IMPEDANCE / MATERIAL ANALYZER HP4338 MILLIOHMMETER Agilent E5071C ENA SERIES NETWORK ANALYZER Keithley 2410 1100V SOURCE METER					

2.PART NUMBER CODE

MCM 2012 B 90 0 G B E
1 2 3 4 5 6 7 8

- 1 Series Name
- 2 Size Code: the first two digitals : length(mm), the last two digitals : width(mm)
- 3 Material Code
- 4 Impedance(Ω) ± 25% γ (ex : 900=90 Ω ; 121=120 Ω)
- 5 Fixed Decimal Point
- 6 Rated Current Code

A=50mA	B=80mA	C=100mA	D=150mA	E=200mA	F=300mA
G=400mA	H=500mA	I =600mA	J =700mA	K=800mA	

- 7 Soldering: Green Parts: A— Soldering Lead-Free B— Lead-Free for whole chip
- 8 Packaging: E Embossed plastic tape, 7" reel.

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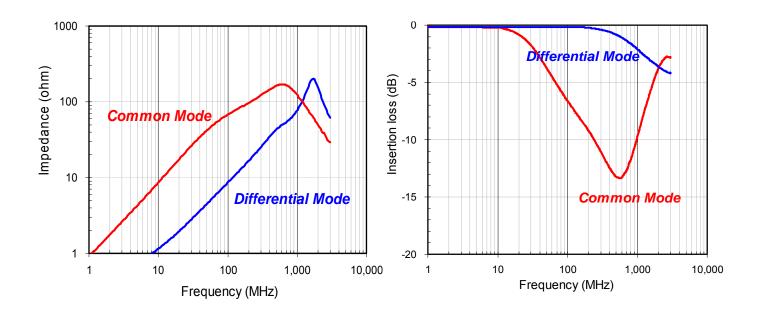


3.TYPICAL CHARACTERISTIC

MCM2012B670

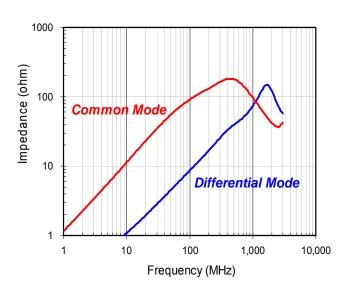
IMPEDANCE vs. FREUQENCY CHARACTERISTICS

INSERTION LOSS vs. FREUQENCY CHARACTERISTICS

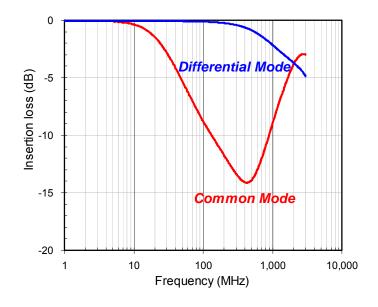


MCM2012B900

IMPEDANCE vs. FREUQENCY CHARACTERISTICS



INSERTION LOSS vs. FREUQENCY CHARACTERISTICS

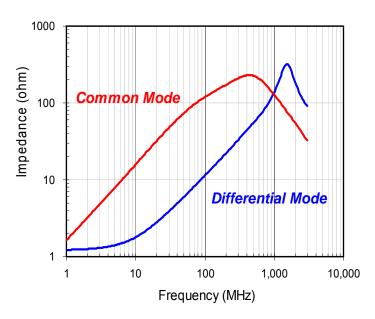


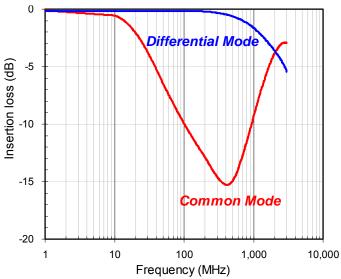


MCM2012B121

IMPEDANCE vs. FREUQENCY CHARACTERISTICS

INSERTION LOSS vs. FREUQENCY CHARACTERISTICS

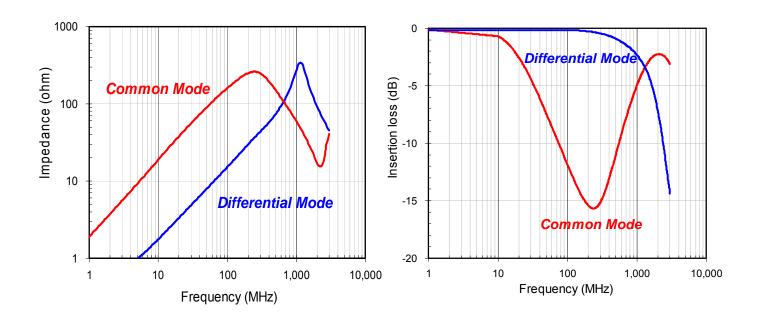




MCM2012B161

IMPEDANCE vs. FREUQENCY CHARACTERISTICS

INSERTION LOSS vs. FREUQENCY CHARACTERISTICS

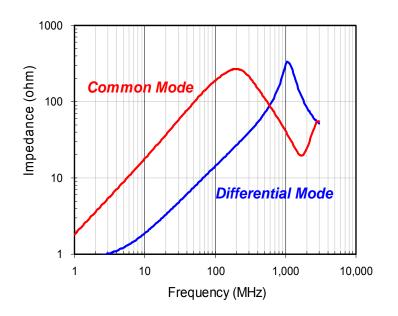


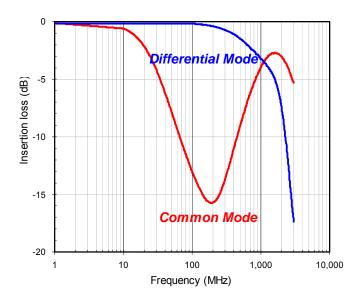


MCM2012B181

IMPEDANCE vs. FREUQENCY CHARACTERISTICS

INSERTION LOSS vs. FREUQENCY CHARACTERISTICS

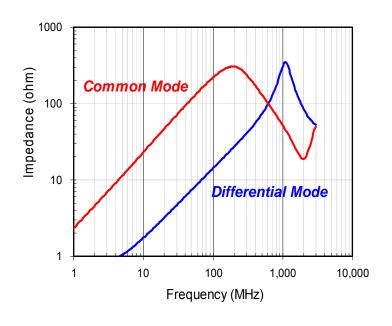


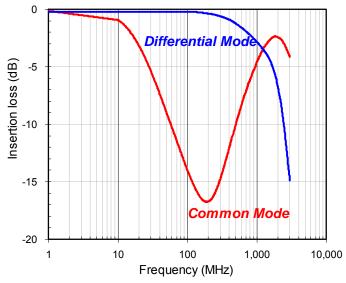


MCM2012B221

IMPEDANCE vs. FREUQENCY CHARACTERISTICS

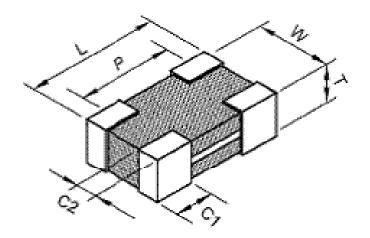
INSERTION LOSS vs. FREUQENCY CHARACTERISTICS







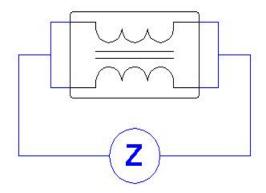
4.SHAPES AND DIMENSIONS



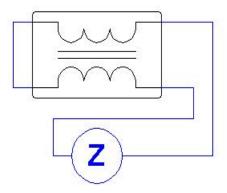
TYPE	2012		
L	2.00±0.20		
W	1.25±0.20		
Т	1.00±0.10		
Р	1.60±0.20		
C1 0.40±0.20			
C2	0.30±0.20		
Unit: mm			

5.MEASURING CIRCUITS

(A):Common mode

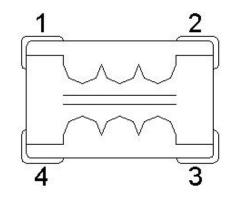


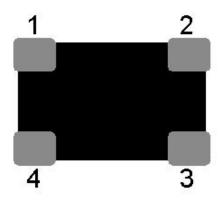
(B):Differential mode

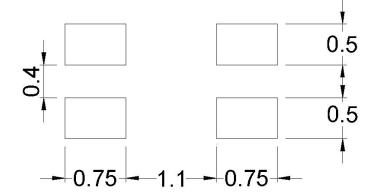




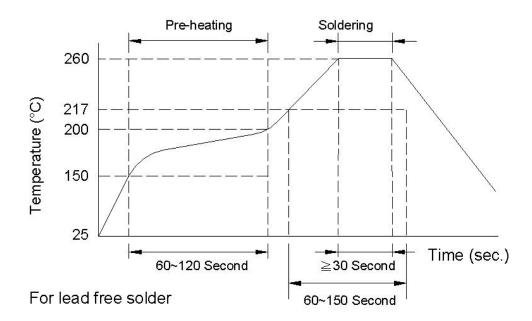
6.CIRCUIT CONFIGURATION & LAYOUT PAD







7.RECOMMENDED SOLDERING CONDITIONS





8.RELIABILITY AND TEST CONDITION

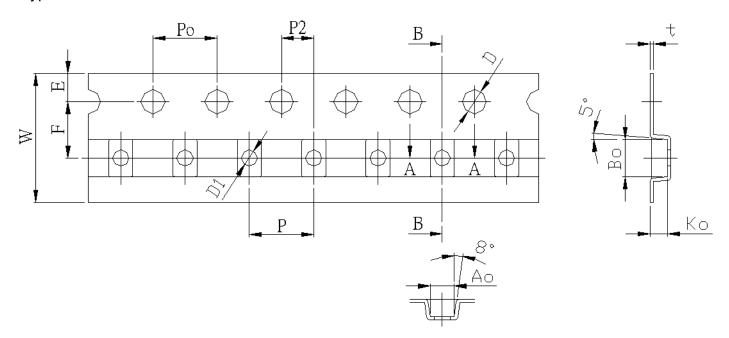
Test item	Test condition	Criteria		
Temperature Cycle	A. Temperature : -40 ~ +85°C			
	B. Cycle: 100 cycles	A. No mechanical damage		
	C. Dwell time: 30minutes	B. Impedance value should be		
		within ± 20 % of the initial		
	Measurement : at ambient temperature	value		
	24 hrs after test completion			
	A. Temperature : 85°C ± 5°C			
Operational Life	B. Test time: 1000 hrs	A. No mechanical damage		
	C. Apply current : full rated current	B. Impedance value should be within ± 20 % of the initial		
	Measurement : at ambient temperature	value		
	24 hrs after test completion			
	A. Temperature : 40 ± 2°C			
	B. Humidity : 90 ~ 95 % RH	A. No mechanical damage		
	C. Test time: 1000 hrs	-		
Biased Humidity	D. Apply current : full rated current	B. Impedance value should be within ± 20 % of the initial		
	Measurement : at ambient temperature	value		
	24 hrs after test completion			
		A. More than 95 % of terminal		
		electrode should be covered		
	A. Solder temperature : 260 ± 5°ℂ	with new solder		
Resistance to Solder Heat	B. Flux : Rosin	B. No mechanical damage		
	C. DIP time: 10 ± 1 sec	C .Impedance value should be		
		within ± 20 % of the initial		
		value		
Steam Aging Test	A. Temperature : 93 ± 2°C			
	B. Test time : 4 hrs(MCA)	More than 95 % of terminal		
	Others: 8 hrs	electrode should be covered		
	C. Solder temperature : 235 ± 5°C	with new solder		
	D. Flux : Rosin	WILLI FIEW SOIGE		
	E. DIP time: 5 ± 1 sec			

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9. TAPE AND REEL SPECIFICATIONS

Type: Plastic Carrier



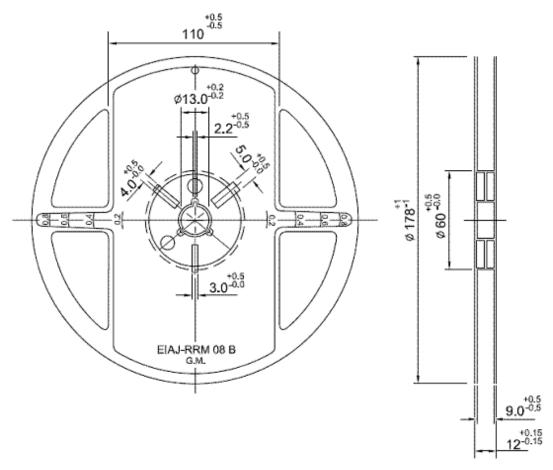
Unit: mm

Symbol	Size	Symbol	Size
W	8.00±0.10	D1	1.00±0.10
Р	4.00±0.10	Po	4.00±0.10
E	1.75±0.10	Ao	1.40±0.10
F	3.50±0.05	Во	2.30±0.10
P2	2.00±0.05	Ko	1.13±0.10
D	1.50 ^{+0.10} _{-0.00}	t	0.22±0.05



10.REEL DIMENSIONS

Unit: mm



11.STANDARD QUANTITY FOR PACKAGING

Packaging style: Taping

Reel packaging quantity: 3000 pcs/reel

Inner box: 5 reel/inner box

12.GENERAL TECHNICAL DATA

Operating temperature range : - 40° C ~ +85 $^{\circ}$ C Storage Condition : Less than 40 $^{\circ}$ C and 70 $^{\circ}$ RH

Storage Time: 6 months Max.

Soldering method: Reflow or Wave Soldering